Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/651,136	SIPKA ET AL.	
Examiner	Art Unit	
Patrick J. Nolan	1644	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventors searched PALM, NPL, LPS allergy, asthma, see search printout.	4/14/2006	PN
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